

PATENT ABSTRACTS OF JAPAN

(11)Publication number : 05-211218

(43)Date of publication of application : 20.08.1993

(51)Int.Cl.

H01L 21/66
G01R 1/073
G01R 31/02
H01H 1/14
H05K 1/11
H05K 3/32

(21)Application number : 04-227543

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(22)Date of filing : 26.08.1992

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(30)Priority

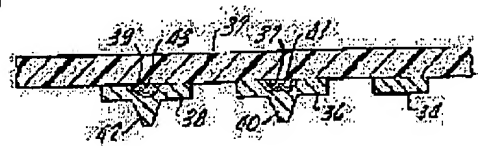
Priority number : 91 750842 Priority date : 26.08.1991 Priority country : US

(54) ELECTRICAL CONNECTION WITH FORMED CONTACTS

(57)Abstract:

PURPOSE: To provide test contacts for an integrated circuit which enables reliable and easy formation of contacts.

CONSTITUTION: A substrate 32 is prepared, a circuit having a plurality of groups of connector pads 34, 36 and 38 arranged in a pattern which is aligned with a pattern of integrated circuit contact pads being formed on the substrate 32. A least one of the groups of connector pads has sharp-pointed contact portions, the pointed contact portions are integrally electroformed with the associated connector pads, and a test is conducted under a condition that the pointed contact portions are pushed against the integrated circuit pads as contacted therewith. The pointed contact portion has a conical or pyramid shape, the top of which is truncated. When such pyramids are pushed against the



pads, the pyramids can pass through oxides on the pads or through foreign matter adhered thereto and be brought into good contact with the pads.

LEGAL STATUS

[Date of request for examination] 26.08.1992

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application converted registration]

[Date of final disposal for application]

[Patent number] 2072901

[Date of registration] 25.07.1996

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]

[Date of extinction of right] 13.11.2002